

Features

- Advanced HEFET Technology
- · Ultra Low On-Resistance
- Excellent QaxRDS(on) Product
- · 100% avalanche tested
- 175°C Operating Temperature
- · Lead Free and Green Devices Available (RoHS Comp.





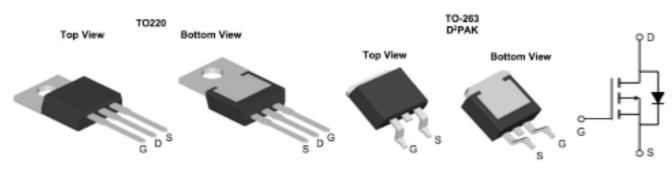


Halogen-Free

- Motor Drives
- Uninterruptible Power Supplies
- DC/DC converter
- · General Purpose Applications

 $V_{DS} = -150V I_{D} = -45A$

 $R_{DS(ON)} < 80 m\Omega$ @ $V_{GS}=10V$



Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
XPX45P15TU	TO-220-3L	XPX45P15TU XXX YYYY	1000
XPX45P15TU	TO-263-3L	XPX45P15TU XXX YYYY	800

Absolute Maximum Ratings (T_C=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-150	V
VGS	Gate-Source Voltage	±20	V
I _D @T _A =25°C	Continuous Drain Current, -V _{GS} @ -10V ¹	-45	А
I _D @T _A =70°C	Continuous Drain Current, -V _{GS} @ -10V ¹	-27.2	А
IDM	Pulsed Drain Current ²	-120	А
EAS	Single Pulse Avalanche Energy ³	402	mJ
IAS	Avalanche Current	48	А
P _D @T _A =25°C	Total Power Dissipation ⁴	65.8	W
TSTG Storage Temperature Range		-55 to 150	℃
T _J Operating Junction Temperature Range		-55 to 150	℃
R _{0JA} Thermal Resistance Junction-Ambient ¹		62.5	°C/W
R _B JC Thermal Resistance Junction-Case ¹		1.5	°C/W



(OHFWULFDO &KDUDFOVHXUQLOVHXVLVFVRW7KHUZLVH QRWHG

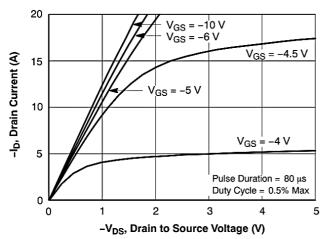
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1RWH

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- 、7KH GDWD WHVWHG E\ S≦XOVXHVG G6XXVØ≜VFI\EOGWK
- 7KH WHVW FRQGLWLRQ LV 9'' TKH (\$6 GDWD VKRZV OD UDWLQJ
- 、7KH SRZHU GLVVLSDWL®R QM K 10 FONLIPR QW HWGH IESHUDW XUH
- 、7KH GDWD LV WKHRUHWLFDOO\ WKH VDPH DV , ' DQG , '0 LQ UHDO DSSOLFD



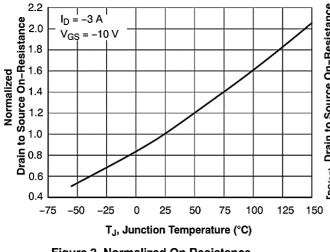
7\SLFDO &KDUDFWHULVWLFV



V_{GS} = -4 V to Source On-Resistance 3 **Normalized Drain** $V_{GS} = -4.5$ 2 V_{GS} = -5 V V_{GS} = -10 V Pulse Duration = 80 μs V_{GS} = -6 V Duty Cycle = 0.5% Max 0 0 10 20 -I_D, Drain Current (A)

Figure 1. On Region Characteristics

Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage



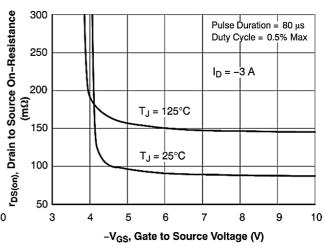
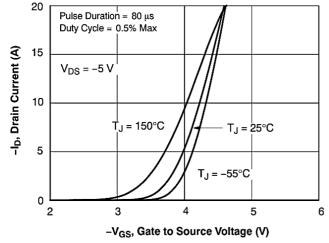


Figure 3. Normalized On Resistance vs. Junction Temperature

Figure 4. On-Resistance vs. Gate to Source Voltage



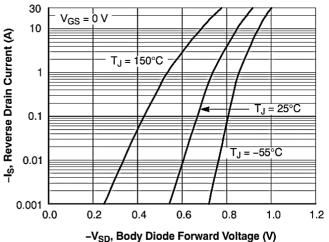
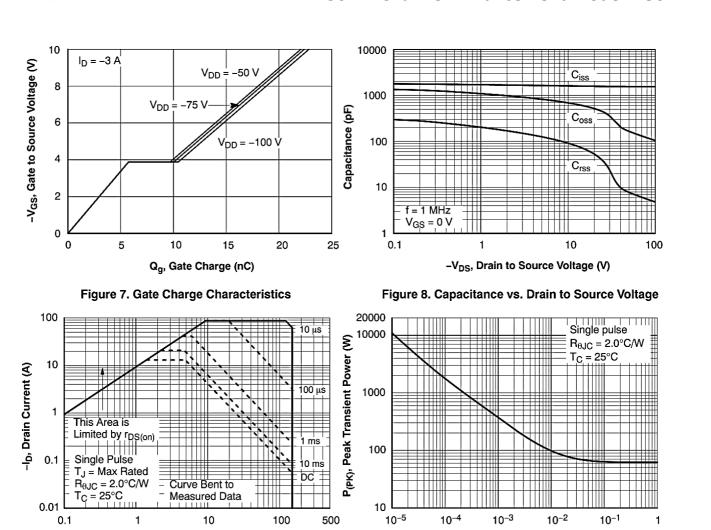


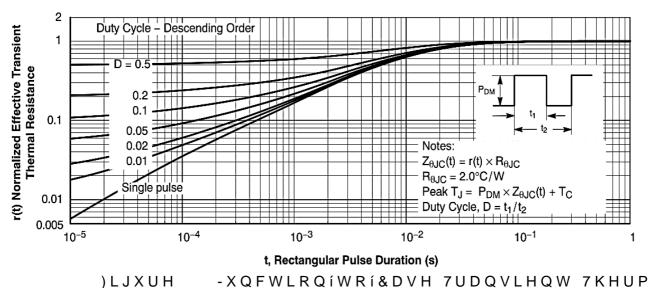
Figure 5. Transfer Characteristics

Figure 6. Source to Drain Diode Forward Voltage vs. Source Current





) RUZDUG %LDV 6DIH 2SHUDWLQJ \$UHD)LJXUH)LJXUH 3RZHU 'LVVLSDWLRQ

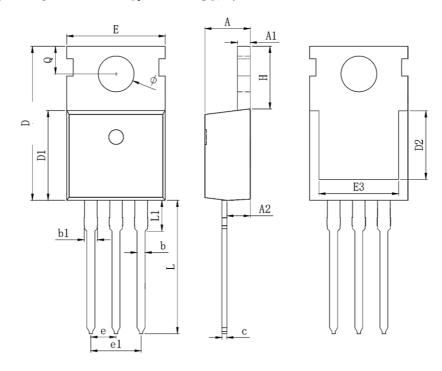


-V_{DS}, Drain to Source Voltage (V)

t, Pulse Width (s)



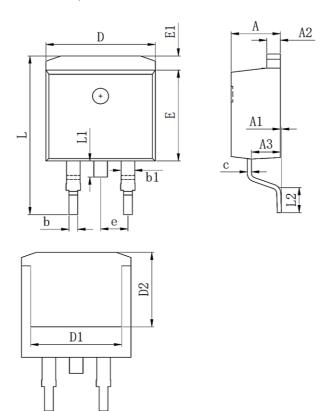
3DFNDJH 0HFKDQLFDO&'/DWD 72



Cymbol	Dim in mm		
Symbol	min	tpy	max
A	4.25	4.5	4.7
A1	1.15	1.3	1.45
A2	2.15	2.35	2.55
b	0.65	0.8	0.95
b1	1.15	1.35	1.55
С	0.35	0.5	0.65
D	14.3	15.3	16.3
D1	8.8	9.1	9.4
D2		6.3REF	
E	9.7	10	10.3
E3	7	8	9
е	2.54BSC		
e1	5.08BSC		
L	12.7	13.5	13.9
L1		3.1	3.4
Н	6	6.5	6.85
Q	2.6	2.8	3
¥	3.4	3.6	3.8



3DFNDJH 0HFKDQLFD0% '/DWD 72



Cymbol		Dim in mm		
Symbol	min	tpy	max	
А	4.37	4.57	4.77	
A1	0		0.25	
A2	1.22	1.27	1.42	
A3	2.49	2.69	2.89	
b	0.7	0.81	0.96	
b1	1.17	1.27	1.47	
С	0.3	0.38	0.53	
D	9.86	10.16	10.36	
D1		8.4REF		
D2		7.073REF		
E	8.5	8.7	8.9	
E1	1.07	1.27	1.47	
е	2.54BSC			
L	17.7	15.1	15.5	
L1	1.4	1.55	1.7	
L2	2	2.3	2.6	
Н	6	6.5	6.85	
Q	2.6	2.8	3	
¥	3.4	3.6	3.8	



Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb device	245℃±5℃	5sec±1sec
Pb-Free device	260℃+0/-5℃	5sec±1sec



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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